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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Submitted to the PTO: November 17, 2005			ATTY DOCKET NO. 00684.102862		APPLICATION NO. To be assigned	
APPLICANTS HIDEKI YOSHINAGA, ET AL.			FILING DATE October 11, 2005		GROUP To be assigned	
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6,489,899	12/2002	Ely, et al.	341	20	
	6,445,489	09/2002	Jacobson, et al.	359	296	
	5,444,190	08/1995	Yamanami, et al.	178	18	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	WO 92/16368	10/1992	PCT			
	0 461 614	12/1991	Europe			
	0 511 406	11/1992	Europe			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
	L. Ferraris, "EMI Shielding-Common Problems and Containment Strategies", Electromagnetic Compatibility Proceedings, International Symposium on Beijing, China, pp. 86-89 (May 21, 1997).					
	V.A. Soglasnova, et al., "Amplitude and Phase Characteristics of Metal Meshes-The Elements of Submillimeter Interference Filters", International Journal of Infrared and Millimeter Waves, Vol. 14, No. 1, pp. 155-168 (January 1993).					
	W. Jing, et al., "The Calculating and Analysis of Shielding Effectiveness of Metal Meshes in Transient Electromagnetic Interference", Environment Electromagnetics, Proceedings, Asia-Pacific Conference of Hangzhou, pp. 379-385 (November 4-7, 2003).					
EXAMINER			DATE CONSIDERED			
/Yuk Chow/			01/27/2011			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 1 of 1

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /Y.C./